

# AD7224–SPECIFICATIONS

**DUAL SUPPLY** ( $V_{DD} = 11.4 \text{ V to } 16.5 \text{ V}$ ,  $V_{SS} = -5 \text{ V} \pm 10\%$ ;  $AGND = DGND = 0 \text{ V}$ ;  $V_{REF} = +2 \text{ V to } (V_{DD} - 4 \text{ V})^1$  unless otherwise noted.  
All specifications  $T_{MIN}$  to  $T_{MAX}$  unless otherwise noted.)

Parameter	K, B, T Versions <sup>2</sup>	L, C, U Versions <sup>2</sup>	Units	Conditions/Comments
STATIC PERFORMANCE				
Resolution	8	8	Bits	V <sub>DD</sub> = +15 V ± 5%, V <sub>REF</sub> = +10 V
Total Unadjusted Error	±2	±1	LSB max	
Relative Accuracy	±1	±1/2	LSB max	
Differential Nonlinearity	±1	±1	LSB max	Guaranteed Monotonic
Full-Scale Error	±3/2	±1	LSB max	V <sub>DD</sub> = 14 V to 16.5 V, V <sub>REF</sub> = +10 V
Full-Scale Temperature Coefficient	±20	±20	ppm/°C max	
Zero Code Error	±30	±20	mV max	
Zero Code Error Temperature Coefficient	±50	±30	µV/°C typ	
REFERENCE INPUT				
Voltage Range	2 to (V <sub>DD</sub> - 4)	2 to (V <sub>DD</sub> - 4)	V min to V max	Occurs when DAC is loaded with all 1s.
Input Resistance	8	8	kΩ min	
Input Capacitance <sup>3</sup>	100	100	pF max	
DIGITAL INPUTS				
Input High Voltage, V <sub>INH</sub>	2.4	2.4	V min	V <sub>IN</sub> = 0 V or V <sub>DD</sub>
Input Low Voltage, V <sub>INL</sub>	0.8	0.8	V max	
Input Leakage Current	±1	±1	µA max	
Input Capacitance <sup>3</sup>	8	8	pF max	
Input Coding	Binary	Binary		
DYNAMIC PERFORMANCE				
Voltage Output Slew Rate <sup>3</sup>	2.5	2.5	V/µs min	V <sub>REF</sub> = +10 V; Settling Time to ±1/2 LSB V <sub>REF</sub> = +10 V; Settling Time to ±1/2 LSB V <sub>REF</sub> = 0 V V <sub>OUT</sub> = +10 V
Voltage Output Settling Time <sup>3</sup>				
Positive Full-Scale Change	5	5	µs max	
Negative Full-Scale Change	7	7	µs max	
Digital Feedthrough	50	50	nV secs typ	
Minimum Load Resistance	2	2	kΩ min	
POWER SUPPLIES				
V <sub>DD</sub> Range	11.4/16.5	11.4/16.5	V min/V max	For Specified Performance
V <sub>SS</sub> Range	4.5/5.5	4.5/5.5	V min/V max	For Specified Performance
I <sub>DD</sub>				
@ 25°C	4	4	mA max	Outputs Unloaded; V <sub>IN</sub> = V <sub>INL</sub> or V <sub>INH</sub>
T <sub>MIN</sub> to T <sub>MAX</sub>	6	6	mA max	Outputs Unloaded; V <sub>IN</sub> = V <sub>INL</sub> or V <sub>INH</sub>
I <sub>SS</sub>				
@ 25°C	3	3	mA max	Outputs Unloaded; V <sub>IN</sub> = V <sub>INL</sub> or V <sub>INH</sub>
T <sub>MIN</sub> to T <sub>MAX</sub>	5	5	mA max	Outputs Unloaded; V <sub>IN</sub> = V <sub>INL</sub> or V <sub>INH</sub>
SWITCHING CHARACTERISTICS <sup>3, 4</sup>				
t <sub>1</sub>				Chip Select/Load DAC Pulse Width
@ 25°C	90	90	ns min	
T <sub>MIN</sub> to T <sub>MAX</sub>	90	90	ns min	
t <sub>2</sub>				Write/Reset Pulse Width
@ 25°C	90	90	ns min	
T <sub>MIN</sub> to T <sub>MAX</sub>	90	90	ns min	
t <sub>3</sub>				Chip Select/Load DAC to Write Setup Time
@ 25°C	0	0	ns min	
T <sub>MIN</sub> to T <sub>MAX</sub>	0	0	ns min	
t <sub>4</sub>				Chip Select/Load DAC to Write Hold Time
@ 25°C	0	0	ns min	
T <sub>MIN</sub> to T <sub>MAX</sub>	0	0	ns min	
t <sub>5</sub>				Data Valid to Write Setup Time
@ 25°C	90	90	ns min	
T <sub>MIN</sub> to T <sub>MAX</sub>	90	90	ns min	
t <sub>6</sub>				Data Valid to Write Hold Time
@ 25°C	10	10	ns min	
T <sub>MIN</sub> to T <sub>MAX</sub>	10	10	ns min	

## NOTES

<sup>1</sup>Maximum possible reference voltage.

<sup>2</sup>Temperature ranges are as follows:

K, L Versions:  $-40^\circ\text{C}$  to  $+85^\circ\text{C}$

B, C Versions:  $-40^\circ\text{C}$  to  $+85^\circ\text{C}$

T, U Versions:  $-55^\circ\text{C}$  to  $+125^\circ\text{C}$

<sup>3</sup>Sample Tested at 25°C by Product Assurance to ensure compliance.

<sup>4</sup>Switching characteristics apply for single and dual supply operation.

Specifications subject to change without notice.

# SINGLE SUPPLY

( $V_{DD} = +15\text{ V} \pm 5\%$ ;  $V_{SS} = \text{AGND} = \text{DGND} = 0\text{ V}$ ;  $V_{REF} = +10\text{ V}^1$  unless otherwise noted.  
All specifications  $T_{MIN}$  to  $T_{MAX}$  unless otherwise noted.)

Parameter	K, B, T Versions <sup>2</sup>	L, C, U Versions <sup>2</sup>	Units	Conditions/Comments
STATIC PERFORMANCE				
Resolution	8	8	Bits	
Total Unadjusted Error	$\pm 2$	$\pm 2$	LSB max	
Differential Nonlinearity	$\pm 1$	$\pm 1$	LSB max	Guaranteed Monotonic
REFERENCE INPUT				
Input Resistance	8	8	k $\Omega$ min	
Input Capacitance <sup>3</sup>	100	100	pF max	Occurs when DAC is loaded with all 1s.
DIGITAL INPUTS				
Input High Voltage, $V_{INH}$	2.4	2.4	V min	
Input Low Voltage, $V_{INL}$	0.8	0.8	V max	
Input Leakage Current	$\pm 1$	$\pm 1$	$\mu\text{A}$ max	$V_{IN} = 0\text{ V}$ or $V_{DD}$
Input Capacitance <sup>3</sup>	8	8	pF max	
Input Coding	Binary	Binary		
DYNAMIC PERFORMANCE				
Voltage Output Slew Rate <sup>4</sup>	2	2	V/ $\mu\text{s}$ min	
Voltage Output Settling Time <sup>4</sup>				
Positive Full-Scale Change	5	5	$\mu\text{s}$ max	Settling Time to $\pm 1/2$ LSB
Negative Full-Scale Change	20	20	$\mu\text{s}$ max	Settling Time to $\pm 1/2$ LSB
Digital Feedthrough <sup>3</sup>	50	50	nV secs typ	$V_{REF} = 0\text{ V}$
Minimum Load Resistance	2	2	k $\Omega$ min	$V_{OUT} = +10\text{ V}$
POWER SUPPLIES				
$V_{DD}$ Range	14.25/15.75	14.25/15.75	V min/V max	For Specified Performance
$I_{DD}$				
@ 25°C	4	4	mA max	Outputs Unloaded; $V_{IN} = V_{INL}$ or $V_{INH}$
$T_{MIN}$ to $T_{MAX}$	6	6	mA max	Outputs Unloaded; $V_{IN} = V_{INL}$ or $V_{INH}$
SWITCHING CHARACTERISTICS <sup>3, 4</sup>				
$t_1$				
@ 25°C	90	90	ns min	Chip Select/Load DAC Pulse Width
$T_{MIN}$ to $T_{MAX}$	90	90	ns min	
$t_2$				
@ 25°C	90	90	ns min	Write/Reset Pulse Width
$T_{MIN}$ to $T_{MAX}$	90	90	ns min	
$t_3$				
@ 25°C	0	0	ns min	Chip Select/Load DAC to Write Setup Time
$T_{MIN}$ to $T_{MAX}$	0	0	ns min	
$t_4$				
@ 25°C	0	0	ns min	Chip Select/Load DAC to Write Hold Time
$T_{MIN}$ to $T_{MAX}$	0	0	ns min	
$t_5$				
@ 25°C	90	90	ns min	Data Valid to Write Setup Time
$T_{MIN}$ to $T_{MAX}$	90	90	ns min	
$t_6$				
@ 25°C	10	10	ns min	Data Valid to Write Hold Time
$T_{MIN}$ to $T_{MAX}$	10	10	ns min	

## NOTES

<sup>1</sup>Maximum possible reference voltage.<sup>2</sup>Temperature ranges are as follows:

AD7224KN, LN: 0°C to +70°C

AD7224BQ, CQ: -25°C to +85°C

AD7224TD, UD: -55°C to +125°C

<sup>3</sup>See Terminology.<sup>4</sup>Sample tested at 25°C by Product Assurance to ensure compliance.

Specifications subject to change without notice.

# AD7224

## ABSOLUTE MAXIMUM RATINGS<sup>1</sup>

$V_{DD}$ to AGND	−0.3 V, +17 V
$V_{DD}$ to DGND	−0.3 V, +17 V
$V_{DD}$ to $V_{SS}$	−0.3 V, +24 V
AGND to DGND	−0.3 V, $V_{DD}$
Digital Input Voltage to DGND	−0.3 V, $V_{DD} + 0.3$ V
$V_{REF}$ to AGND	−0.3 V, $V_{DD} + 0.3$ V
$V_{OUT}$ to AGND <sup>2</sup>	− $V_{SS}$ , $V_{DD}$
Power Dissipation (Any Package) to +75°C	450 mW
Derates above 75°C by	6 mW/°C
Operating Temperature	
Commercial (K, L Versions)	−40°C to +85°C
Industrial (B, C Versions)	−40°C to +85°C
Extended (T, U Versions)	−55°C to +125°C
Storage Temperature	−65°C to +150°C
Lead Temperature (Soldering, 10 secs)	+300°C

## NOTES

<sup>1</sup>Stresses above those listed under “Absolute Maximum Ratings” may cause permanent damage to the device. This is a stress rating only and functional operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

<sup>2</sup>The outputs may be shorted to AGND provided that the power dissipation of the package is not exceeded. Typically short circuit current to AGND is 60 mA.

## ORDERING GUIDE

Model <sup>1</sup>	Temperature Range	Total Unadjusted Error (LSB)	Package Option <sup>2</sup>
AD7224KN	−40°C to +85°C	±2 max	N-18
AD7224LN	−40°C to +85°C	±1 max	N-18
AD7224KP	−40°C to +85°C	±2 max	P-20A
AD7224LP	−40°C to +85°C	±1 max	P-20A
AD7224KR-1	−40°C to +85°C	±2 max	R-20
AD7224LR-1	−40°C to +85°C	±1 max	R-20
AD7224KR-18	−40°C to +85°C	±2 max	R-18
AD7224LR-18	−40°C to +85°C	±1 max	R-18
AD7224BQ	−40°C to +85°C	±2 max	Q-18
AD7224CQ	−40°C to +85°C	±1 max	Q-18
AD7224TQ	−55°C to +125°C	±2 max	Q-18
AD7224UQ	−55°C to +125°C	±1 max	Q-18
AD7224TE	−55°C to +125°C	±2 max	E-20A
AD7224UE	−55°C to +125°C	±1 max	E-20A

## NOTES

<sup>1</sup>To order MIL-STD-883 processed parts, add /883B to part number.

Contact your local sales office for military data sheet.

<sup>2</sup>E = Leadless Ceramic Chip Carrier; N = Plastic DIP;

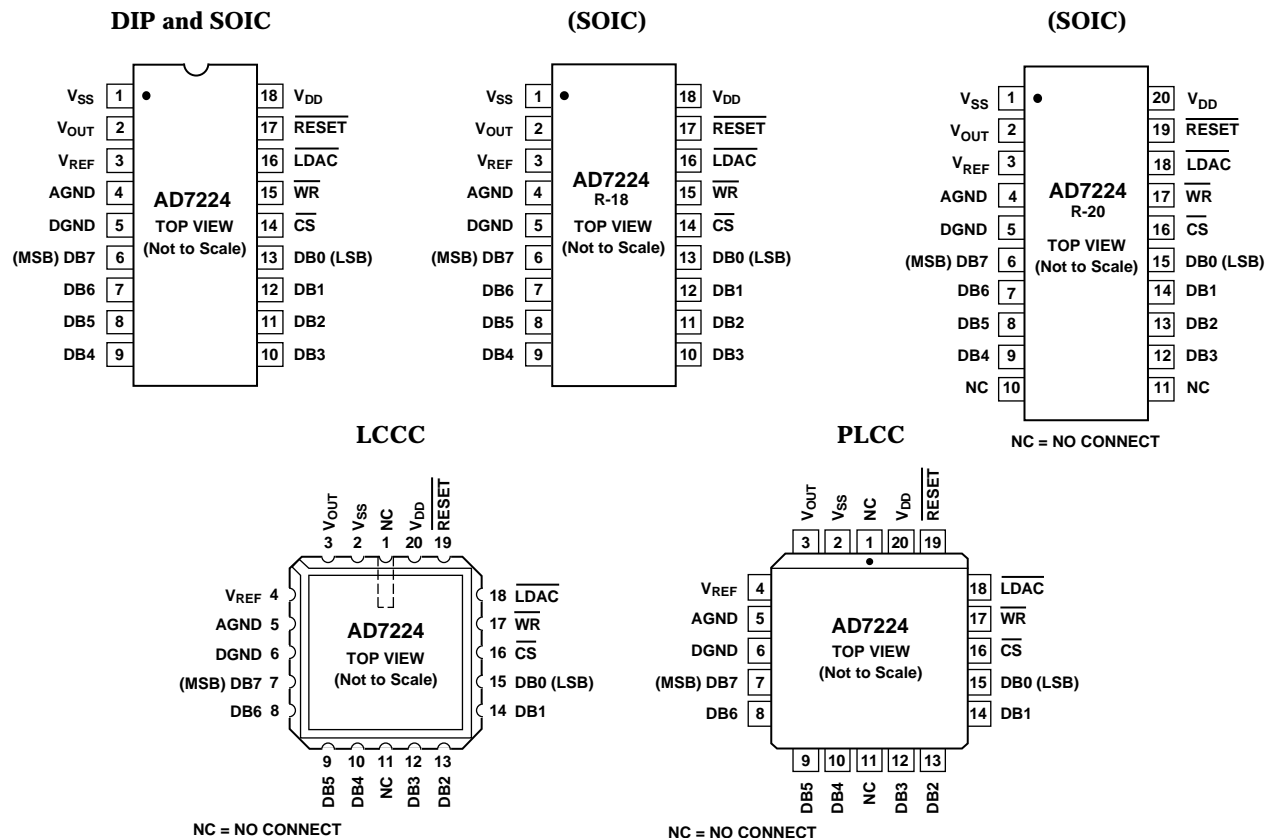
P = Plastic Leaded Chip Carrier; Q = Cerdip; R = SOIC.

## CAUTION

ESD (electrostatic discharge) sensitive device. Electrostatic charges as high as 4000 V readily accumulate on the human body and test equipment and can discharge without detection. Although the AD7224 features proprietary ESD protection circuitry, permanent damage may occur on devices subjected to high energy electrostatic discharges. Therefore, proper ESD precautions are recommended to avoid performance degradation or loss of functionality.



## PIN CONFIGURATIONS



## TERMINOLOGY

### TOTAL UNADJUSTED ERROR

Total Unadjusted Error is a comprehensive specification which includes full-scale error, relative accuracy and zero code error. Maximum output voltage is  $V_{REF} - 1 \text{ LSB}$  (ideal), where 1 LSB (ideal) is  $V_{REF}/256$ . The LSB size will vary over the  $V_{REF}$  range. Hence the zero code error, relative to the LSB size, will increase as  $V_{REF}$  decreases. Accordingly, the total unadjusted error, which includes the zero code error, will also vary in terms of LSBs over the  $V_{REF}$  range. As a result, total unadjusted error is specified for a fixed reference voltage of +10 V.

### RELATIVE ACCURACY

Relative Accuracy or endpoint nonlinearity is a measure of the maximum deviation from a straight line passing through the endpoints of the DAC transfer function. It is measured after allowing for zero code error and full-scale error and is normally expressed in LSBs or as a percentage of full-scale reading.

### DIFFERENTIAL NONLINEARITY

Differential Nonlinearity is the difference between the measured change and the ideal 1 LSB change between any two adjacent codes. A specified differential nonlinearity of  $\pm 1 \text{ LSB}$  max over the operating temperature range ensures monotonicity.

### DIGITAL FEEDTHROUGH

Digital Feedthrough is the glitch impulse transferred to the output due to a change in the digital input code. It is specified in nV secs and is measured at  $V_{REF} = 0 \text{ V}$ .

### FULL-SCALE ERROR

Full-Scale Error is defined as:

$$\text{Measured Value} - \text{Zero Code Error} - \text{Ideal Value}$$

## CIRCUIT INFORMATION

### D/A SECTION

The AD7224 contains an 8-bit voltage-mode digital-to-analog converter. The output voltage from the converter has the same polarity as the reference voltage, allowing single supply operation. A novel DAC switch pair arrangement on the AD7224 allows a reference voltage range from +2 V to +12.5 V.

The DAC consists of a highly stable, thin-film, R-2R ladder and eight high speed NMOS single pole, double-throw switches. The simplified circuit diagram for this DAC is shown in Figure 1.

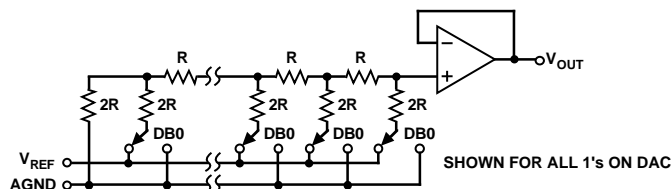


Figure 1. D/A Simplified Circuit Diagram

The input impedance at the  $V_{REF}$  pin is code dependent and can vary from 8 k $\Omega$  minimum to infinity. The lowest input impedance occurs when the DAC is loaded with the digital code 01010101. Therefore, it is important that the reference presents a low output impedance under changing load conditions. The nodal capacitance at the reference terminals is also code dependent and typically varies from 25 pF to 50 pF.

The  $V_{OUT}$  pin can be considered as a digitally programmable voltage source with an output voltage of:

$$V_{OUT} = D \cdot V_{REF}$$

where  $D$  is a fractional representation of the digital input code and can vary from 0 to 255/256.

### OP-AMP SECTION

The voltage-mode D/A converter output is buffered by a unity gain noninverting CMOS amplifier. This buffer amplifier is capable of developing +10 V across a 2 k $\Omega$  load and can drive capacitive loads of 3300 pF.

The AD7224 can be operated single or dual supply resulting in different performance in some parameters from the output amplifier. In single supply operation ( $V_{SS} = 0 \text{ V} = \text{AGND}$ ) the sink capability of the amplifier, which is normally 400  $\mu\text{A}$ , is reduced as the output voltage nears AGND. The full sink capability of 400  $\mu\text{A}$  is maintained over the full output voltage range by tying  $V_{SS}$  to -5 V. This is indicated in Figure 2.

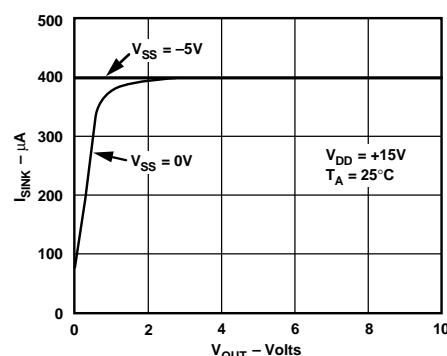


Figure 2. Variation of  $I_{SINK}$  with  $V_{OUT}$

Settling-time for negative-going output signals approaching AGND is similarly affected by  $V_{SS}$ . Negative-going settling-time for single supply operation is longer than for dual supply operation. Positive-going settling-time is not affected by  $V_{SS}$ .

Additionally, the negative  $V_{SS}$  gives more headroom to the output amplifier which results in better zero code performance and improved slew-rate at the output, than can be obtained in the single supply mode.

### DIGITAL SECTION

The AD7224 digital inputs are compatible with either TTL or 5 V CMOS levels. All logic inputs are static-protected MOS gates with typical input currents of less than 1 nA. Internal input protection is achieved by an on-chip distributed diode between DGND and each MOS gate. To minimize power supply currents, it is recommended that the digital input voltages be driven as close to the supply rails ( $V_{DD}$  and DGND) as practically possible.

### INTERFACE LOGIC INFORMATION

Table I shows the truth table for AD7224 operation. The part contains two registers, an input register and a DAC register.  $\overline{\text{CS}}$  and  $\overline{\text{WR}}$  control the loading of the input register while  $\overline{\text{LDAC}}$  and  $\overline{\text{WR}}$  control the transfer of information from the input register to the DAC register. Only the data held in the DAC register will determine the analog output of the converter.

All control signals are level-triggered and therefore either or both registers may be made transparent; the input register by keeping  $\overline{\text{CS}}$  and  $\overline{\text{WR}}$  "LOW", the DAC register by keeping  $\overline{\text{LDAC}}$  and  $\overline{\text{WR}}$  "LOW". Input data is latched on the rising edge of  $\overline{\text{WR}}$ .

# AD7224

**Table I. AD7224 Truth Table**

<b>RESET</b>	<b>LDAC</b>	<b>WR</b>	<b>CS</b>	<b>Function</b>
H	L	L	L	Both Registers are Transparent
H	X	H	X	Both Registers are Latched
H	H	X	H	Both Registers are Latched
H	H	L	L	Input Register Transparent
H	H	$\overline{L}$	L	Input Register Latched
H	L	L	H	DAC Register Transparent
H	L	$\overline{L}$	H	DAC Register Latched
L	X	X	X	Both Registers Loaded With All Zeros
$\overline{L}$	H	H	H	Both Register Latched With All Zeros and Output Remains at Zero
$\overline{L}$	L	L	L	Both Registers are Transparent and Output Follows Input Data

H = High State, L = Low State, X = Don't Care.

All control inputs are level triggered.

The contents of both registers are reset by a low level on the RESET line. With both registers transparent, the RESET line functions like a zero override with the output brought to 0 V for the duration of the RESET pulse. If both registers are latched, a “LOW” pulse on RESET will latch all 0s into the registers and the output remains at 0 V after the RESET line has returned “HIGH”. The RESET line can be used to ensure power-up to 0 V on the AD7224 output and is also useful, when used as a zero override, in system calibration cycles. Figure 3 shows the input control logic for the AD7224.

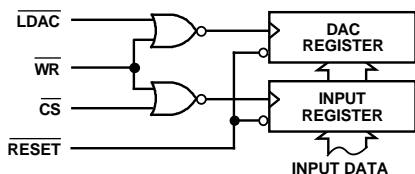
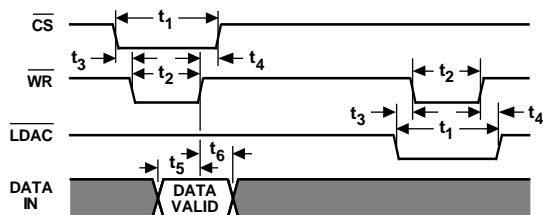


Figure 3. Input Control Logic



**NOTES:**

1. ALL INPUT SIGNAL RISE AND FALL TIMES MEASURED FROM 10% TO 90% OF  $V_{DD}$ .  
 $t_r = t_f = 20\text{ns}$  OVER  $V_{DD}$  RANGE
2. TIMING MEASUREMENT REFERENCE LEVEL IS  $\frac{V_{INH} + V_{INL}}{2}$

Figure 4. Write Cycle Timing Diagram

## SPECIFICATION RANGES

For the DAC to maintain specified accuracy, the reference voltage must be at least 4 V below the  $V_{DD}$  power supply voltage. This voltage differential is required for correct generation of bias voltages for the DAC switches.

With dual supply operation, the AD7224 has an extended  $V_{DD}$  range from  $+12\text{ V} \pm 5\%$  to  $+15\text{ V} \pm 10\%$  (i.e., from  $+11.4\text{ V}$  to  $+16.5\text{ V}$ ). Operation is also specified for a single  $V_{DD}$  power supply of  $+15\text{ V} \pm 5\%$ .

Performance is specified over a wide range of reference voltages from 2 V to ( $V_{DD} - 4$  V) with dual supplies. This allows a range of standard reference generators to be used such as the AD580,

a +2.5 V bandgap reference and the AD584, a precision +10 V reference. Note that in order to achieve an output voltage range of 0 V to +10 V, a nominal +15 V  $\pm$  5% power supply voltage is required by the AD7224.

## GROUND MANAGEMENT

AC or transient voltages between AGND and DGND can cause noise at the analog output. This is especially true in microprocessor systems where digital noise is prevalent. The simplest method of ensuring that voltages at AGND and DGND are equal is to tie AGND and DGND together at the AD7224. In more complex systems where the AGND and DGND intertie is on the backplane, it is recommended that two diodes be connected in inverse parallel between the AD7224 AGND and DGND pins (IN914 or equivalent).

## Applying the AD7224

### UNIPOLAR OUTPUT OPERATION

This is the basic mode of operation for the AD7224, with the output voltage having the same positive polarity as  $V_{REF}$ . The AD7224 can be operated single supply ( $V_{SS} = AGND$ ) or with positive/negative supplies (see op-amp section which outlines the advantages of having negative  $V_{SS}$ ). Connections for the unipolar output operation are shown in Figure 5. The voltage at  $V_{REF}$  must never be negative with respect to DGND. Failure to observe this precaution may cause parasitic transistor action and possible device destruction. The code table for unipolar output operation is shown in Table II.

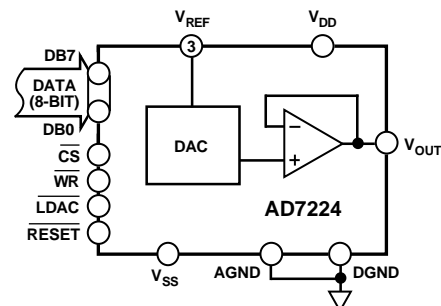


Figure 5. Unipolar Output Circuit

### Table III. Unipolar Code Table

DAC Register Contents		Analog Output
MSB	LSB	
1 1 1 1	1 1 1 1	$+V_{REF}\left(\frac{255}{256}\right)$
1 0 0 0	0 0 0 1	$+V_{REF}\left(\frac{129}{256}\right)$
1 0 0 0	0 0 0 0	$+V_{REF}\left(\frac{128}{256}\right) = +\frac{V_{REF}}{2}$
0 1 1 1	1 1 1 1	$+V_{REF}\left(\frac{127}{256}\right)$
0 0 0 0	0 0 0 1	$+V_{REF}\left(\frac{1}{256}\right)$
0 0 0 0	0 0 0 0	0 V

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Note: 1  $LSB = (V_{REF})(2^{-8}) = V_{REF}\left(\frac{1}{256}\right)$

## BIPOLAR OUTPUT OPERATION

The AD7224 can be configured to provide bipolar output operation using one external amplifier and two resistors. Figure 6 shows a circuit used to implement offset binary coding. In this case

$$V_O = \left(1 + \frac{R_2}{R_1}\right) \cdot (D \cdot V_{REF}) - \left(\frac{R_2}{R_1}\right) \cdot (V_{REF})$$

With  $R_1 = R_2$

$$V_O = (2D - 1) \cdot V_{REF}$$

where  $D$  is a fractional representation of the digital word in the DAC register.

Mismatch between  $R_1$  and  $R_2$  causes gain and offset errors; therefore, these resistors must match and track over temperature. Once again, the AD7224 can be operated in single supply or from positive/negative supplies. Table III shows the digital code versus output voltage relationship for the circuit of Figure 6 with  $R_1 = R_2$ .

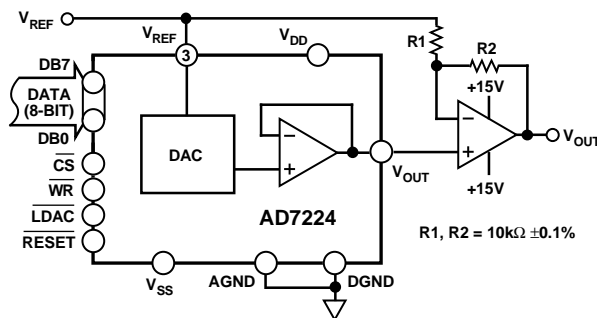


Figure 6. Bipolar Output Circuit

Table III. Bipolar (Offset Binary) Code Table

DAC Register Contents		Analog Output
MSB	LSB	
1 1 1 1	1 1 1 1	$+V_{REF} \left( \frac{127}{128} \right)$
1 0 0 0	0 0 0 1	$+V_{REF} \left( \frac{1}{128} \right)$
1 0 0 0	0 0 0 0	$0 V$
0 1 1 1	1 1 1 1	$-V_{REF} \left( \frac{1}{128} \right)$
0 0 0 0	0 0 0 1	$-V_{REF} \left( \frac{127}{128} \right)$
0 0 0 0	0 0 0 0	$-V_{REF} \left( \frac{128}{128} \right) = -V_{REF}$

## AGND BIAS

The AD7224 AGND pin can be biased above system GND (AD7224 DGND) to provide an offset "zero" analog output voltage level. Figure 7 shows a circuit configuration to achieve this. The output voltage,  $V_{OUT}$ , is expressed as:

$$V_{OUT} = V_{BIAS} + D \cdot (V_{IN})$$

where  $D$  is a fractional representation of the digital word in DAC register and can vary from 0 to 255/256.

For a given  $V_{IN}$ , increasing AGND above system GND will reduce the effective  $V_{DD} - V_{REF}$  which must be at least 4 V to ensure specified operation. Note that  $V_{DD}$  and  $V_{SS}$  for the AD7224 must be referenced to DGND.

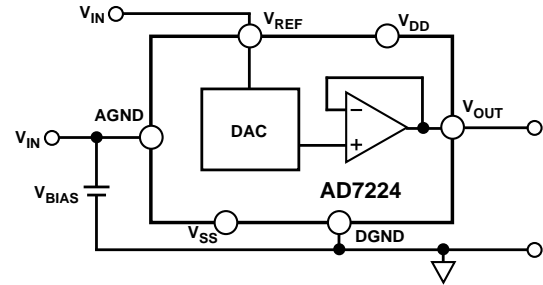


Figure 7. AGND Bias Circuit

## MICROPROCESSOR INTERFACE

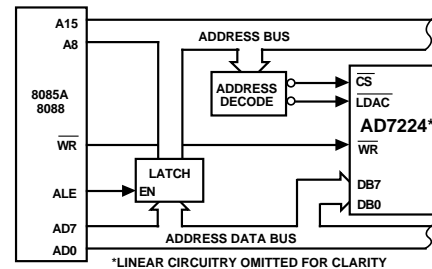


Figure 8. AD7224 to 8085A/8088 Interface

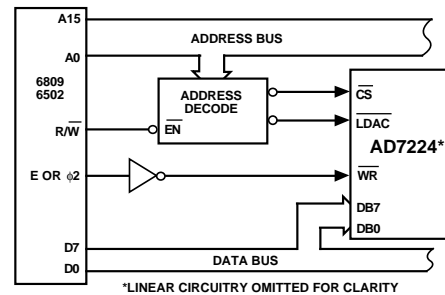


Figure 9. AD7224 to 6809/6502 Interface

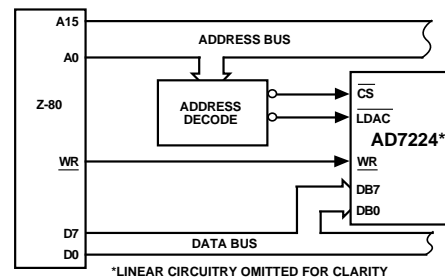


Figure 10. AD7224 to Z-80 Interface

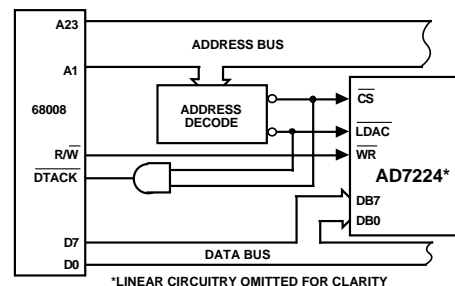
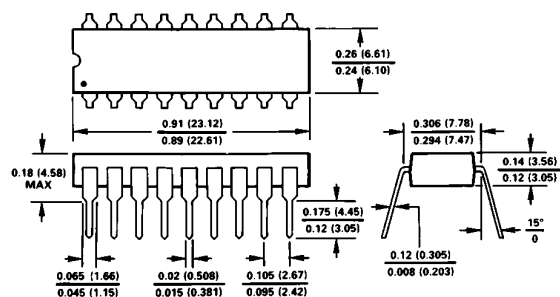


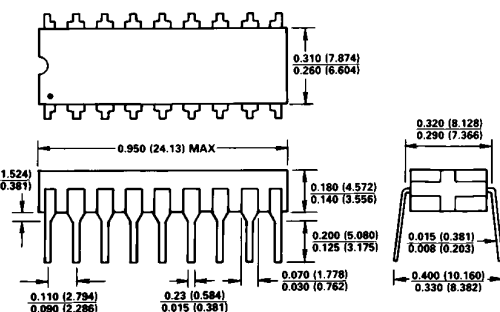
Figure 11. AD7224 to 68008 Interface



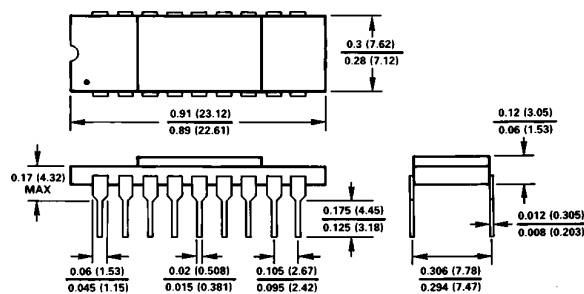
# **OUTLINE DIMENSIONS** Dimensions shown in inches and (mm).

**18-Pin Plastic (Suffix N)**

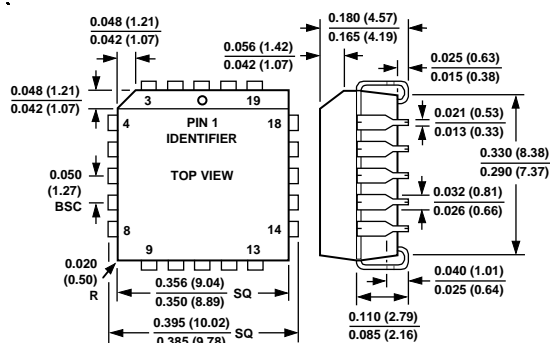
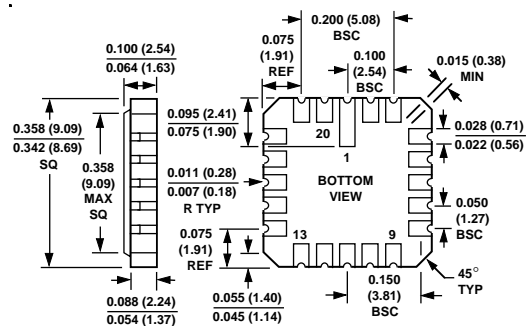
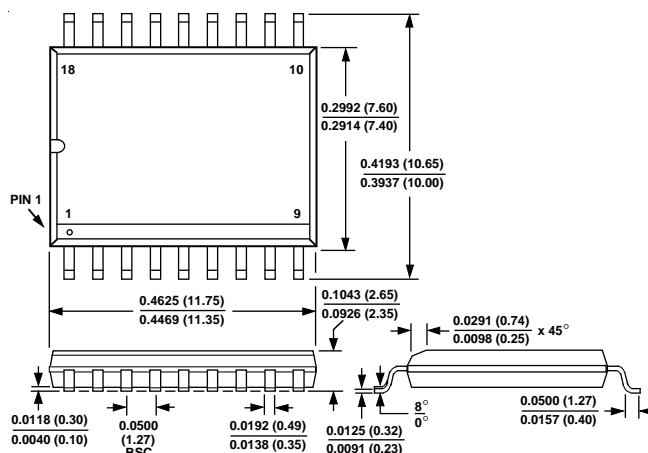
NOTES:  
1. LEAD NO. 1 IDENTIFIED BY DOT OR NOTCH.  
2. CERAMIC DIP LEADS WILL BE EITHER GOLD OR TIN PLATED IN ACCORDANCE WITH MIL-M-38510 REQUIREMENTS.

**18-Pin Cerdip (Suffix Q)**

NOTES:  
1. LEAD NO. 1 IDENTIFIED BY DOT OR NOTCH.  
2. CERAMIC DIP LEADS WILL BE EITHER GOLD OR TIN PLATED IN ACCORDANCE WITH MIL-M-38510 REQUIREMENTS.

**18-Pin Ceramic (Suffix D)**

NOTES:  
1. LEAD NO. 1 IDENTIFIED BY DOT OR NOTCH.  
2. CERAMIC DIP LEADS WILL BE EITHER GOLD OR TIN PLATED IN ACCORDANCE WITH MIL-M-38510 REQUIREMENTS.

**PLCC Package  
P-20A****LCCC Package  
E-20A****18-Lead SOIC  
(R-18)****20-Lead SOIC  
(R-20)**